

**Search Notes**

Application/Control No.

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Examiner

Tan V. Mai

Applicant(s)/Patent under  
Reexamination

CHA ET AL.

Art Unit

2193

**SEARCHED**

Class	Subclass	Date	Examiner
updated	search	5/18/2007	MAI

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated search and NEW search(see search history printout(s))	5/18/2007	MAI